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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Appl. No.

10/661,319

Applicant(s)

Robert L. Armstrong, et al.

Filed

September 12, 2003

Title

OPTICAL DEVICES AND METHODS EMPLOYING NANOPARTICLES,

MICROCAVITIES AND SEMICONTINUOUS METAL FILMS

TC/A.U.

2877

Examiner

Docket No.

37000-9906

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SIR:

Pursuant to 37 C.F.R. §§ 1.97 and 1.98 and to the duty of disclosure set forth in 37 C.F.R. § 1.56, the Examiner in charge of the above-identified application is requested to consider and make of record the references listed on the PTO 1449 submitted herewith. A copy of each of the listed references is also enclosed.

Although the information submitted herewith may be "material" to the Examiner's consideration of the subject application, this submission is not intended to constitute an admission that such information is "prior references" as to the claimed invention.

In accordance with 37 C.F.R. § 1.97(g), the filing of this Information Disclosure Statement shall not be construed to mean that a search has been made.

This Information Disclosure Statement is being filed within three months of the filing date of the application or prior to the mailing date of a first Office action. Therefore, no fee or certification is required. 37 C.F.R. § 1.97(b).

Respectfully submitted,

Deborah A. Peacock, Reg. No. 31,649

Direct line: (505) 998-1501

Enclosures:

PTO Form(s) 1449;

Copy of Reference(s)

Peacock, Myers & Adams, P.C. Attorneys for Applicant P.O. Box 26927 Albuquerque, NM 87125-6927 (505) 998-1500 FAX (505) 243-2542 Customer No. 005179

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U.S. PATE	NT DOCU	MENTS						
Examiner Initials	Cite No.1	1	Kind Code 2 (if known)	Name of Paten Applicant of C Document	Cited	Date of Publication of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	
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Under the Paperwork Reduction Act of 1995 no persons are required to respond to a collection of information unless it contains a valid OMB control number. Substitute for form 1449A/PTO COMPLETE IF KNOWN INFORMATION DISCLOSURE Application Number 101661,319 STATEMENT BY APPLICANT Filing Date September 12, 2003 First Named Inventor (use as many sheets as necessary) Armstrong, et al. Group Art Unit 2877 **Examiner Name** Sheet 2 of 13 15 Attorney Docket Number 37000 CIP2 9906 U.S. PATENT DOCUMENTS Examiner Cite U.S. Patent Document Name of Patentee or Date of Initials Pages, Columns, Lines, No.1 Applicant of Cited Kind Code 2 **Publication** Where Relevant Document of Cited Number (if known) Passages or Relevant **Document** Figures Appear 5,405,906 A.W. Olsen, et al. 04/11/1995 5,469,018 S.M. Jacobsen, et al. 11/21/1995 5,478,658 A. Dodabalapur, et al. 12/26/1995 5,616,986 S.M. Jacobsen, et al. 04/01/1997 5,674,636 A. Dodabalapur, et al. 10/07/1997 5,853,464 I.A. Macpherson, et al. 12/29/1998 LEFT INTENTIONALLY BLANK FOREIGN PATENT DOCUMENTS **Examiner Initials** Cite Foreign Patent Document Name of Patentee of Date of Pages, Columns, Lines No. Kind Applicant of Cited Publication Where Relevant Code 5 Office 3 Number 4 Document of Cited Passages or Relevant Document (if known) Figures Appear T Examiner Date Considered Signature

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OTHER PR	IOR ART -	NON PATENT LITERATURE DOCUMENTS	
Examiner Initials	Cite No. 1	Include name of the author (in CAPITAL LETTERS), title of article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published	T ²
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STATEMENT BY APPLICANT	Filing Date	September 12, 2003			
				First Named Inventor	ARMSTRONG, et al.
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Examiner Initials	Cite No. 1	Include name of the author (in CAPITAL LETTERS), title of article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s),	T ²
		publisher, city and/or country where published	
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